

**Search Notes**

Application/Control No.

10/667,776

Examiner

Young J. Kim

Applicant(s)/Patent under  
Reexamination

SU ET AL.

Art Unit

1637

**SEARCHED**

Class	Subclass	Date	Examiner
422	80	5/16/2005	
	82.01	5/16/2005	
	82.02	5/16/2005	
	82.05	5/16/2005	
435	6	5/16/2005	

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB)	5/16/2005	YJK
See enclosed for search strategy	5/16/2005	YJK